Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10592959	TAKEZAWA, HIDEHARU
Examiner	Art Unit
JACOB BUCHANAN	1725

SEARCHED				
Class	Subclass	Date	Examiner	
429	122-225	4/28/2009	EAN	
	updated above class/subclass search	12/3/2009	jb	
	updated above class/subclass search	11/1/2010	jb	

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST text search, see search history	4/29/2009	EAN		
PLUS search	3/9/2009	EAN		
Google search: mAh, milliamp hour	4/28/2009	EAN		
Inventor name search, PALM	4/29/2009	EAN		
Updated EAST text search, see search history	12/3/2009	jb		
Updated Inventor name search, eDan	12/3/2009	jb		
Updated EAST text search, see search history	11/1/2010	jb		
Updated Inventor name search, eDan	11/1/2010	jb		
J. Crepeau, Primary 1725, re. claim interpretation and search assistance	11/2/2010	jb		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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